

# Search Notes



Application/Control No.

10/750,355

Examiner

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Applicant(s)/Patent under  
Reexamination

MATHIEU ET AL.

Art Unit

2833

## SEARCHED

Class	Subclass	Date	Examiner
439	68	3/11/2006	EAL
	682		
	61-63		
	616		
update search		10/11/05	ENC
update search		4/26/06	ENC
update search		10/1/06	ENC
update search		7/24/07	ENC
update search		7/13/07	ENC
update search		1/3/07	ENC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All of the above		1/3/07	ENC
EAST word		1/3/07	ENC
Search (Jel)			
Interference (Search Notes)			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXAM
Plus Search	1/3/07	ENC
EAST word search (see Search Notes)	1/3/07	ENC
Intentional Search (PALM):	1/3/07	ENC
Checked Patents 6,672,075; 6,268,015 6,255,126 for	1/3/07	ENC
Double Patenting	1/3/07	ENC